Search Notes



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Applicant(s)/Patent Under Reexamination

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Examiner Pardo, Thuy N Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
707	10	8/30/2007	TP
455	186.1	8/30/2007	TP
715	210, 802	2/16/2008	TP
707	10	9/28/2008	TP
715	802	9/28/2008	TP
707	2, 3, 5,7, 101, 102, 104.1	4/9/2009	TP

SEARCH NOTES

Search Notes	Date	Examiner
WEST	8/30/2007	TP
WEST, NPL (IEEE)	2/16/2008	TP
WEST, NPL (ACM)	9/28/2008	TP
WEST, Google Scholar, Multiple Databases	4/9/2009	TP

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner	
707	2, 3, 5,7, 10, 101, 102, 103, 104.1	4/9/2009	TP	
455	186.1	4/9/2009	TP	
715	210, 802	4/9/2009	TP	

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